

# APPROVAL SHEET

## WA06X

Customer

±1%, Convex Type

Precision chip resistors array Size 0603x4

Approval No :	_
Issue Date :	_
Customer Approval :	
Castomer Approvar.	

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#### **FEATURE**

- 1. Small size and light weight
- 2. Reduced size of final equipment
- 3. Lower surface mounted assembly costs
- 4. Higher component and equipment reliability
- 5. Lead (Pb) free terminations is available.

#### **APPLICATION**

- Consumer electrical equipment
- EDP, Computer application
- Telecom

#### **DESCRIPTION**

The resistors array is constructed in a high grade ceramic body (aluminum oxide). Internal metal electrodes are added at each end and connected by a resistive paste that is applied to the top surface of the substrate. The composition of the paste is adjusted to give the approximate resistance required and the value is trimmed to within tolerance by laser cutting of this resistive layer.

The resistive layer is covered with a protective coat. Finally, the two external end terminations are added. For ease of soldering the outer layer of these end terminations is a Lead-tin or Tin (Pb free) solder alloy.

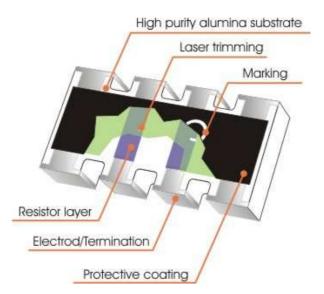


Fig 1. Consctruction of a Chip-R array WA06X 1% product

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## **QUICK REFERENCE DATA**

Item	General Specification
Series No.	WA06X(Convex)
Size	0603x4 (1608x4)
Resistance Tolerance	±1%
Resistance Range	$10\Omega \sim 1M\Omega$
TCR (ppm/°C) 10Ω≤R<1MΩ R<10Ω, R>1MΩ	≤±100 -
Max. dissipation at T <sub>amb</sub> =70°C	1/10 W
Max. Operation Voltage (DC or RMS)	50V
Max. overload voltage	100V
Climatic category	55/155/56

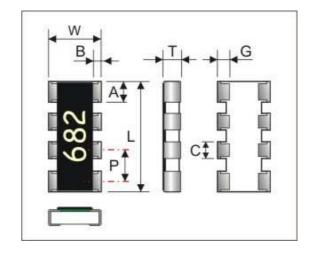
#### Note:

- 1. This is the maximum voltage that may be continuously supplied to the resistor element, see "IEC publication 60115-8"
- 2. Max. Operation Voltage: So called RCWV (Rated Continuous Working Voltage) is determined by

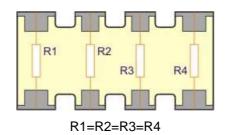
 $RCWV = \sqrt{Rated\,Power \times Resistance\,Value} \,\, \text{or Max. RCWV listed above, whichever is lower.}$ 

#### **Dimensions**

	WA06X		
L	3.20 ± 0.10		
W	1.60 ± 0.10		
Т	$0.50 \pm 0.10$		
Р	$0.80 \pm 0.10$		
<b>A</b> 0.60 ± 0.10			
В	$0.30 \pm 0.10$		
С	0.40 ± 0.10		
G	$0.30 \pm 0.20$		



#### CONSTRUCTION



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#### Marking

#### E24 series resistance : 3-digits marking

Each resistor is marked with a three digits code on the protective coating to designate the nominal resistance value. For values up to 9.1 the R is used as a decimal point. For values of 10.0 or greater the first 2 digits apply to the resistance value and third indicate the number of zeros to follow.

#### **Example**

RESISTANCE	10Ω	12Ω	100Ω	6800Ω	47000Ω
3-digits marking	100	12R	101	682	473

E96 series resistance : No marking

#### **FUNCTIONAL DESCRIPTION**

#### Product characterization

Standard values of nominal resistance are taken from the E24/E96 series for resistors with a tolerance of  $\pm 1\%$ , The values of the E24/E96 series are in accordance with "IEC publication 60063"

#### Derating

The power that the resistor can dissipate depends on the operating temperature; see Fig.2

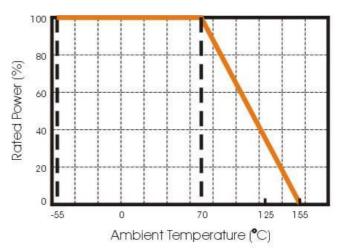


Figure 2. Maximum dissipation in percentage of rated power

As a function of the ambient temperature

#### **MOUNTING**

Due to their rectangular shapes and small tolerances, Surface Mountable Resistors are suitable for handling by automatic placement systems.

Chip placement can be on ceramic substrates and printed-circuit boards (PCBs).

Electrical connection to the circuit is by individual soldering condition.

The end terminations guarantee a reliable contact.

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#### **SOLDERING CONDITION**

The robust construction of chip resistors allows them to be completely immersed in a solder bath of 260°C for 10 seconds. Therefore, it is possible to mount Surface Mount Resistors on one side of a PCB and other discrete components on the reverse (mixed PCBs).

Surface Mount Resistors are tested for solderability at 245°C during 3 seconds. The test condition for no leaching is 260°C for 30 seconds. Typical examples of soldering processes that provide reliable joints without any damage are given in Fig 3.

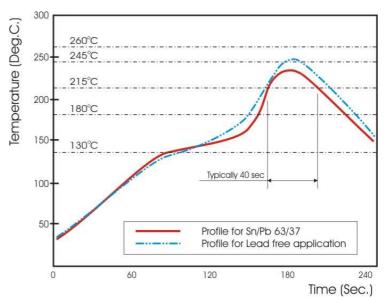


Fig 3. Infrared soldering profile for Chip Resistors array

#### **CATALOGUE NUMBERS**

The resistors have a catalogue number starting with .

WA06	x	472_	F	Т	L
Size code	Type code	Resistance code	Tolerance	Packaging code	Termination code
WA06:0603 per element	X : x4, convex	E24 : 2 significant digits followed by no. of zeros and a blank $10\Omega = 100\_$ $220\Omega = 221\_$ $Jumper = 000\_$ ("_" means a blank) $E96 : 3 significant digits followed by no. of zeros$ $102\Omega = 1020$ $37.4K\Omega = 3742$	J:±5% F:±1% P:Jumper	T: 7" Reel taping B: Bulk	L = Sn base (lead free)

1. Reeled tape packaging: 8mm width paper taping 5000pcs per reel.

2. Bulk packaging : 5000pcs per polybag

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#### **TEST AND REQUIREMENTS(JIS C 5201-1: 1998)**

Essentially all tests are carried out according to the schedule of IEC publication 115-8, category LCT/UCT/56(rated temperature range: Lower Category Temperature, Upper Category Temperature; damp heat, long term, 56 days). The testing also meets the requirements specified by EIA, EIAJ and JIS.

The tests are carried out in accordance with IEC publication 68, "Recommended basic climatic and mechanical robustness testing procedure for electronic components" and under standard atmospheric conditions according to IEC 60068-1, subclause 5.3. Unless otherwise specified, the following value supplied:

Temperature: 15°C to 35°C. Relative humidity: 45% to 75%.

Air pressure: 86kPa to 106 kPa (860 mbar to 1060 mbar). All soldering tests are performed with midly activated flux.

TEST	DDOCEDIDE	REQUIREMENT		
1501	PROCEDURE	Resistor	Jumper	
DC resistance Clause 4.5	DC resistance values measured at the test voltages specified below : $<10\Omega@0.1V,<100\Omega@0.3V,<1K\Omega@1.0V,<10K\Omega@3V, <100K\Omega@10V, <1M\Omega@25V,<10M\Omega@30V$	Within the specified tolerance	< 50mΩ	
Temperature Coefficient of Resistance (T.C.R)  Clause 4.8	Natural resistance change per change in degree centigrade. $\frac{R_2-R_1}{R_1(t_2-t_1)}\times 10^6 \text{ (ppm/°C)} \qquad t_1:20\text{°C+5°C-1°C}$ $R_1: \text{Resistance at reference temperature}$ $R_2: \text{Resistance at test temperature}$	Refer to "QUICK REFERENCE DATA"	N/a	
Short time overload (S.T.O.L) Clause 4.13	Permanent resistance change after a 5second application of a voltage 2.5 times RCWV or the maximum overload voltage specified in the above list, whichever is less.	$\Delta$ R/R max. ±(2%+0.10 $\Omega$ )	< 50mΩ	
Resistance to soldering heat(R.S.H)	Un-mounted chips completely immersed for 10±1second in a SAC solder bath at 255 $^{\circ}\text{C}$ ±5 $^{\circ}\text{C}$	$\Delta$ R/R max. ±(1%+0.05 $\Omega$ ) no visible damage	< 50mΩ	
IEC 60068-2-58: 2004				
Solderability IEC 60068-2-58: 2004	Un-mounted chips completely immersed for 3±0.3second in a SAC solder bath at 245 $^{\circ}\!$	good tinning (>95% covered) no visible damage		
Temperature cycling Clause 4.19	30 minutes at -55°C±3°C, 2~3 minutes at 20℃+5℃-1℃, 30 minutes at +155°C±3°C, 2~3 minutes at 20℃+5℃-1℃, total 5 continuous cycles	$\Delta$ R/R max. ±(1%+0.05 $\Omega$ ) no visible damage	< 50mΩ	
Load life (endurance) Clause 4.25	1000 +48/-0 hours, loaded with RCWV or Vmax in chamber controller 70±2°C, 1.5 hours on and 0.5 hours off	$\Delta$ R/R max.±(3%+0.10 $\Omega$ )  For 10 $\Omega$ ≤R<1M $\Omega$ ; $\Delta$ R/R max.±(5%+0.10 $\Omega$ )  For R<10 $\Omega$ , R≥1M $\Omega$	< 50mΩ	
Load life in Humidity Clause 4.24	1000 +48/-0 hours, loaded with RCWV or Vmax in humidity chamber controller at 40°C±2°C and 90~95% relative humidity, 1.5hours on and 0.5 hours off	$\Delta$ R/R max.±(3%+0.10 $\Omega$ ) For 10 $\Omega$ ≤R<1M $\Omega$ ; $\Delta$ R/R max.±(5%+0.10 $\Omega$ ) For R<10 $\Omega$ , R≥1M $\Omega$	< 50mΩ	
Adhesion Clause 4.32	Pressurizing force: 5N, Test time: 10±1sec.	No remarkable damage or renthe terminations.	noval of	

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## **Walsin Technology Corporation**

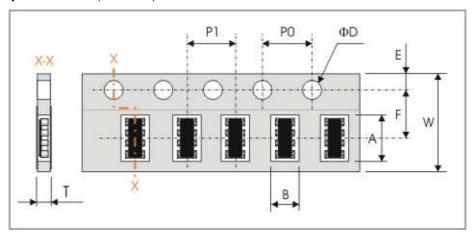
TEST	PROCEDURE	REQUIREMENT
Insulation Resistance JISC5201-1:1998 Clause 4.6	Apply the maximum overload voltage (DC) for 1minutes	R≥10GΩ
Dielectric Withstand Voltage JISC5201-1:1998 Clause 4.7	Apply the maximum overload voltage (AC) for 1 minutes	No breakdown or flashover

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## **PACKAGING**

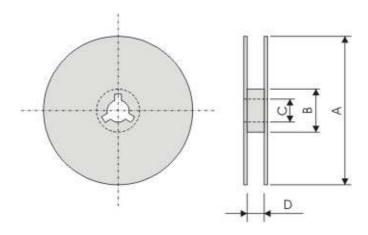
## Paper Tape specifications (unit :mm)



Symbol	Α	В	W	F	E
dimension	3.60±0.20	2.00±0.20	8.00±0.30	3.50±0.20	1.75±0.10

Symbol	P1	P0	ΦD	Т
dimension	4.00±0.10	4.00±0.10	$\Phi$ 1.50 $^{+0.1}_{-0.0}$	Max. 1.0

## **Reel dimensions**



Symbol	А	В	С	D
(unit : mm)	Φ178.0±2.0	Φ60.0±1.0	13.0±0.2	9.0±0.5

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